

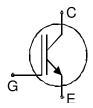
## High Speed IGBT Chip in NPT-technology

## FEATURES:

- low Eoff
- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient easy paralleling
- This chip is used for:
- SGW50N60HS

## Applications:

- Welding
  - PFC
  - UPS



Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code	
SIGC42T60UN	600V	50A	6.5 x 6.5 mm <sup>2</sup>	sawn on foil	SP0001-01820	

### **MECHANICAL PARAMETER:**

Raster size	6.5 x 6.5				
Area total / active	42.25 / 35.6				
Emitter pad size	2x( 3.0x2.85 )				
Gate pad size	0.8 x 1.5				
Thickness	100	μm			
Wafer size	150	mm			
Flat position	90	deg			
Max.possible chips per wafer	334				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	AI, ≤500µm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, Tj=25 °C	V <sub>CE</sub>	600	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	А
Pulsed collector current, $t_p$ limited by $T_{jmax}$	I <sub>cpuls</sub>	150	Α
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55 +150	°C

<sup>1)</sup> depending on thermal properties of assembly

**STATIC CHARACTERISTICS** (tested on chip),  $T_j$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
	0,	oonanoono	min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0V, I <sub>C</sub> =2mA	600			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =50A		2.8	3.15	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_{C}$ =1mA, $V_{GE}$ = $V_{CE}$	3	4	5	
Zero gate voltage collector current	I <sub>CES</sub>	$V_{CE}$ =600V, $V_{GE}$ =0V			40	μA
Gate-emitter leakage current	I <sub>GES</sub>	$V_{CE}$ =0V, $V_{GE}$ =20V			120	nA

## **DYNAMIC CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
Falameter			min.	typ.	max.	
Input capacitance	Ciss	$V_{CE}=25V$	-	2572		pF
Output capacitance	Coss	$V_{\rm GE}=0$ V	-	245		
Reverse transfer capacitance	Crss	f=1MHz	-	158		

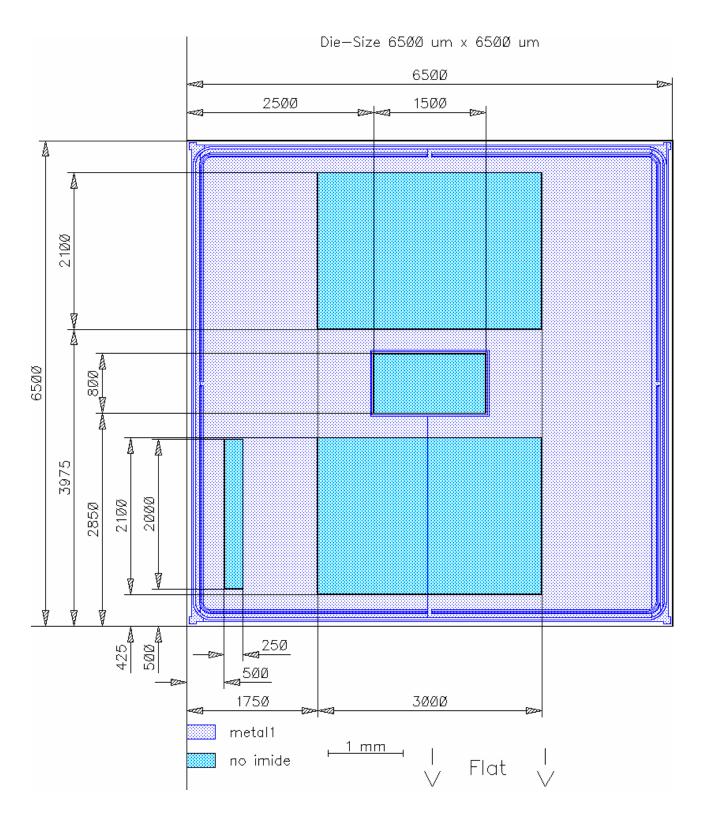
### SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions*	Value			Unit
			min.	typ.	max.	
Turn-on delay time	t <sub>d(on)</sub>	$T_{\rm j} = 150^{\circ} \rm C$	-	48		ns
Rise time	t <sub>r</sub>	V <sub>CC</sub> =400V I <sub>C</sub> =50A V <sub>GE</sub> =+15/0V	-	31		
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE}$ = +15/0V $R_{\rm G}$ = 6.8 $\Omega$	-	350		
Fall time	t <sub>f</sub>		-	20		

\* Values also influenced by parasitic L- and C- in measurement and package.



## **CHIP DRAWING:**



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## FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

SGW50N60HS

Package :TO247

#### **Description:**

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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